Silicon N Channel DV-L MOS FET High Speed Power Switching

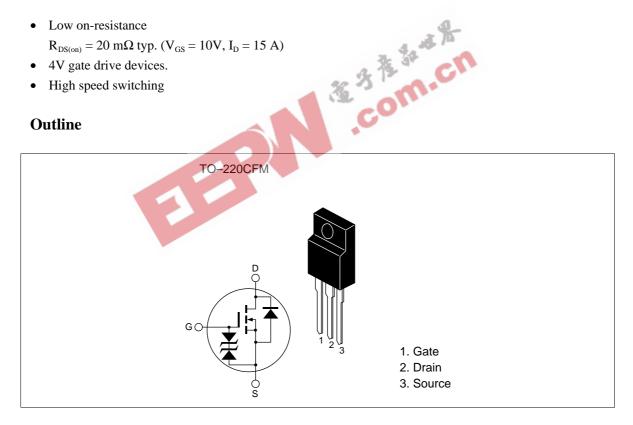
HITACHI

ADE-208-544 1st. Edition

Features

- Low on-resistance $R_{\rm DS(on)} = 20~\text{m}\Omega$ typ. ($V_{\rm GS} = 10\text{V},~I_{D} = 15~\text{A})$
- 4V gate drive devices.
- High speed switching

Outline





Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit					
Drain to source voltage	V _{DSS}	30	V					
Gate to source voltage	$V_{\sf GSS}$	±20	V					
Drain current	I _D	30	A					
Drain peak current	I _{D(pulse)} *1	120	A					
Body to drain diode reverse drain current	I _{DR}	30	A					
Channel dissipation	Pch*2	25	W					
Channel temperature	Tch	150	°C					
Storage temperature	Tstg	-55 to +150	°C					
Notes: 1. PW ≤ 10μs, duty cycle ≤ 1 % 2. Value at Tc = 25°C								



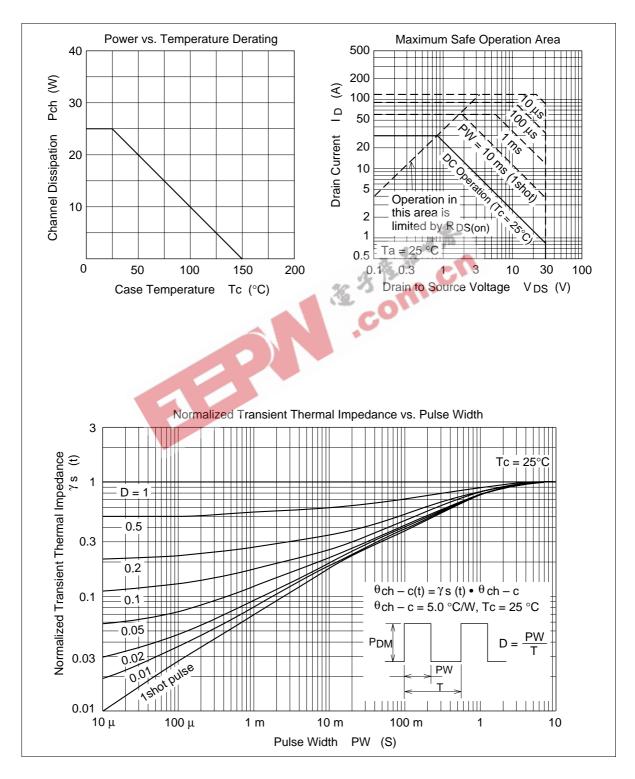
Electrical Characteristics ($Ta = 25^{\circ}C$)

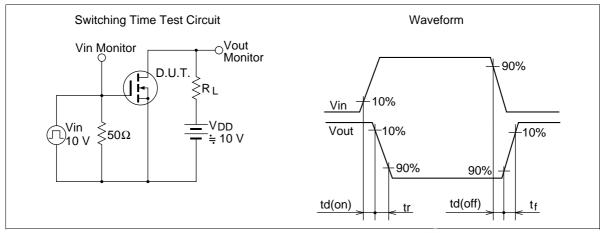
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	30	_	_	V	$I_{D} = 10 \text{mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±20	_	_	V	$I_{G} = \pm 100 \mu A, V_{DS} = 0$
Zero gate voltege drain current	I _{DSS}	_	_	10	μΑ	$V_{DS} = 30 \text{ V}, V_{GS} = 0$
Gate to source leak current	I _{GSS}	_	_	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.0	_	2.0	V	$I_D = 1 \text{mA}, V_{DS} = 10 \text{V}$
Static drain to source on state	$R_{\text{DS(on)}}$	_	20	28	m $Ω$	$I_D = 15A, V_{GS} = 10V^{*1}$
resistance	R _{DS(on)}		35	50	$m\Omega$	$I_D = 15A, V_{GS} = 4V^{*1}$
Forward transfer admittance	y _{fs}	12	18	_	S	$I_D = 15A, V_{DS} = 10V^{*1}$
Input capacitance	Ciss	_	750	- 4	pF	$V_{DS} = 10V$
Output capacitance	Coss	_	520	2-13	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	210	<u>-</u> -1	pF	f = 1MHz
Turn-on delay time	t _{d(on)}	-	16	GU.	ns	V _{GS} = 10V, I _D = 15A
Rise time	t,	# /	26 0	_	ns	$R_L = 0.67\Omega$
Turn-off delay time	t _{d(off)}	7	85	_	ns	_
Fall time	t		90	_	ns	_
Body to drain diode forward voltage	V _{DF}	_	1.0	_	V	$I_F = 30A, V_{GS} = 0$
Body to drain diode reverse recovery time	t _{rr}	_	45	_	ns	$I_F = 30A, V_{GS} = 0$ diF/ dt = 50A/ μ s

Note: 1. Pulse test

See characteristics curves of 2SK2684

Main Characteristics

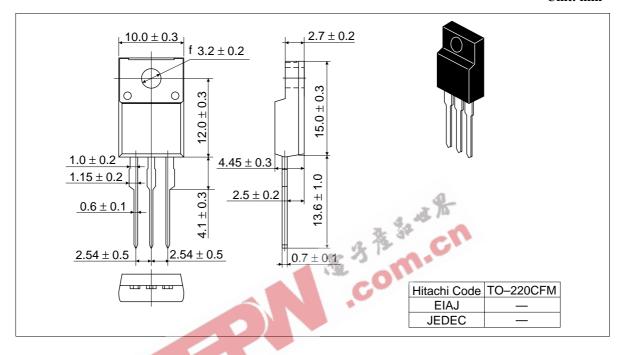






Package Dimensions

Unit: mm



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